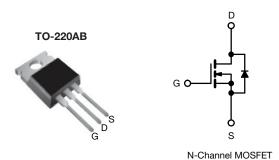


Power MOSFET



PRODUCT SUMMARY					
V _{DS} (V)	80	800			
R _{DS(on)} (Ω)	V _{GS} = 10 V	3.0			
Q _g max. (nC)	7	78			
Q _{gs} (nC)	9.	9.6			
Q _{gd} (nC)	4	45			
Configuration	Sin	Single			

FEATURES

- Dynamic dV/dt rating
- Repetitive avalanche rated
- · Fast switching
- · Ease of paralleling
- Simple drive requirements
- Material categorization: for definitions of compliance please see <u>www.vishay.com/doc?99912</u>

Note

* This datasheet provides information about parts that are RoHS-compliant and / or parts that are non RoHS-compliant. For example, parts with lead (Pb) terminations are not RoHS-compliant. Please see the information / tables in this datasheet for details

DESCRIPTION

Third generation power MOSFETs from Vishay provide the designer with the best combination of fast switching, ruggedized device design, low on-resistance and cost-effectiveness.

The TO-220AB package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 W. The low thermal resistance and low package cost of the TO-220AB contribute to its wide acceptance throughout the industry.

ORDERING INFORMATION	
Package	TO-220AB
Lead (Pb)-free	IRFBE30PbF
Lead (Pb)-free and halogen-free	IRFBE30PbF-BE3

PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-source voltage			V _{DS}	800	V	
Gate-source voltage			V_{GS}	± 20		
Continuous drain current	V _{GS} at 10 V	T _C = 25 °C		4.1	А	
		T _C = 100 °C	I _D	2.6		
Pulsed drain current ^a			I _{DM}	16	1	
Linear derating factor				1.0	W/°C	
Single pulse avalanche energy b			E _{AS}	260	mJ	
Repetitive avalanche current ^a			I _{AR}	4.1	А	
Repetitive avalanche energy ^a			E _{AR}	13	mJ	
Maximum power dissipation	$T_C = 1$	25 °C	P _D	125	W	
Peak diode recovery dV/dt ^c			dV/dt	2.0	V/ns	
Operating junction and storage temperature range			T _J , T _{stg}	-55 to +150	°C	
Soldering recommendations (peak temperature) d	For 10 s			300		
Mauring town	6-32 or M3 screw			10	lbf ⋅ in	
Mounting torque				1.1	N⋅m	

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. V_{DD} = 50 V, starting T_J = 25 °C, L = 29 mH, R_g = 25 Ω , I_{AS} = 4.1 A (see fig. 12)
- c. $I_{SD} \le 4.1$ A, $dI/dt \le 100$ A/ μ s, $V_{DD} \le 600$, $T_J \le 150$ °C
- d. 1.6 mm from case



Vishay Siliconix

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYP.	MAX.	UNIT	
Maximum junction-to-ambient	R _{thJA}	-	62		
Case-to-sink, flat, greased surface	R _{thCS}	0.50	-	°C/W	
Maximum junction-to-case (drain)	R _{thJC}	-	1.0		

PARAMETER	SYMBOL	TES1	MIN.	TYP.	MAX.	UNIT	
Static						•	
Drain-source breakdown voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_{D} = 250 \mu\text{A}$		800	-	-	V
V _{DS} temperature coefficient	$\Delta V_{DS}/T_{J}$	Reference to 25 °C, I _D = 1 mA		-	0.9	-	V/°C
Gate-source threshold voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$		2.0	-	4.0	V
Gate-source leakage	I _{GSS}	V _{GS} = ± 20 V		-	-	± 100	nA
7	,	V _{DS} = 800 V, V _{GS} = 0 V	-	-	100	μА	
Zero gate voltage drain current	I _{DSS}	$V_{DS} = 640 \text{ V},$	V _{DS} = 640 V, V _{GS} = 0 V, T _J = 125 °C		-		500
Drain-source on-state resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 2.5 A ^b	-	-	3.0	Ω
Forward transconductance	9 _{fs}	$V_{DS} = 1$	100 V, I _D = 2.5 A ^b	2.5	-	-	S
Dynamic							
Input capacitance	C _{iss}		-	1300	-	pF	
Output capacitance	C _{oss}	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz}, \text{ see fig. } 5$		-	310		-
Reverse transfer capacitance	C _{rss}			-	190		-
Total gate charge	Qg		I _D = 4.1 A, V _{DS} = 400 V, see fig. 6 and 13 ^b	-	-	78	nC
Gate-source charge	Q _{gs}	V _{GS} = 10 V		-	-	9.6	
Gate-drain charge	Q _{gd}			-	-	45	
Turn-on delay time	t _{d(on)}			-	12	-	
Rise time	t _r	V_{DD} = 400 V, I_{D} = 4.1 A R_{g} = 12 Ω , R_{D} = 95 Ω , see fig. 10 ^b		-	33	-	- ns
Turn-off delay time	t _{d(off)}			-	82	-	
Fall time	t _f			-	30	-	
Gate input resistance	R _g	f = 1 MHz, open drain		0.6	-	1.6	Ω
Internal drain inductance	L _D	Between lead, 6 mm (0.25") from package and center of die contact		-	4.5	-	- nH
Internal source inductance	L _S			-	7.5	-	1117
Drain-Source Body Diode Characteristic	es						
Continuous source-drain diode current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	4.1	- A
Pulsed diode forward current ^a	I _{SM}			-	-	16	_ ^
Body diode voltage	V _{SD}	$T_J = 25 ^{\circ}\text{C}, I_S = 4.1 \text{A}, V_{GS} = 0 \text{V}^{ \text{b}}$		-	-	1.8	V
Body diode reverse recovery time	t _{rr}	T _J = 25 °C, I _F = 4.1 A, dI/dt = 100 A/μs b		_	480	720	ns
Body diode reverse recovery charge	Q _{rr}			-	1.8	2.7	μC
Forward turn-on time	t _{on}	Intrinsic tur	n-on time is negligible (turn	on is do	minated b	y L _S and	L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11)
- b. Pulse width $\leq 300~\mu s;~duty~cycle \leq 2~\%$



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

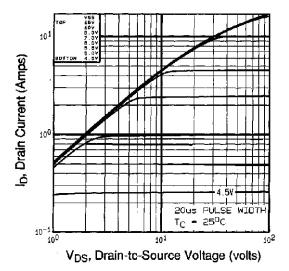


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

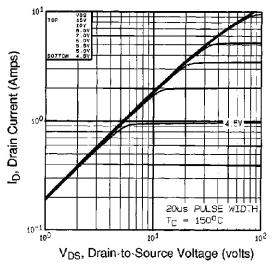
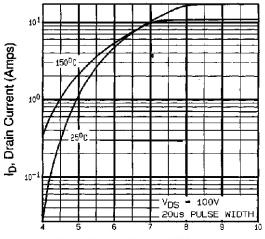


Fig. 2 - Typical Output Characteristics, $T_C = 150$ °C



V_{GS}, Gate-to-Source Voltage (volts)

Fig. 3 - Typical Transfer Characteristics

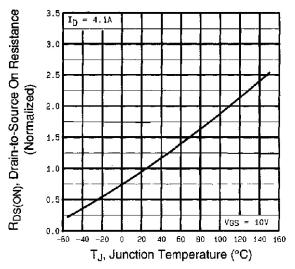


Fig. 4 - Normalized On-Resistance vs. Temperature



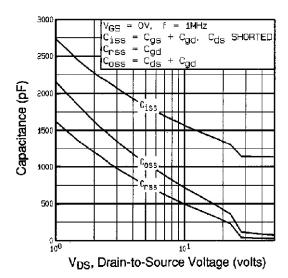


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

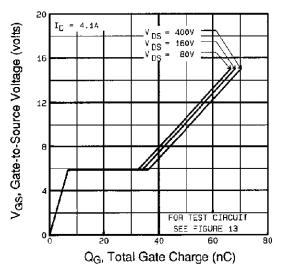


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

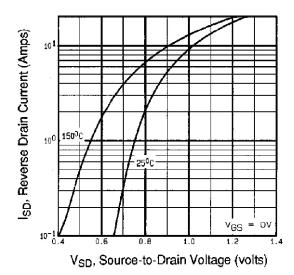


Fig. 7 - Typical Source-Drain Diode Forward Voltage

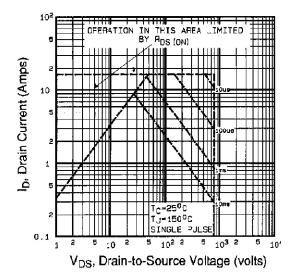


Fig. 8 - Maximum Safe Operating Area



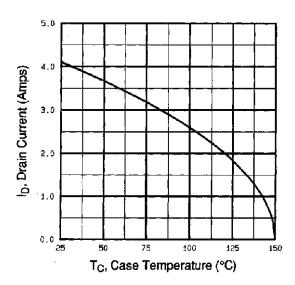


Fig. 9 - Maximum Drain Current vs. Case Temperature

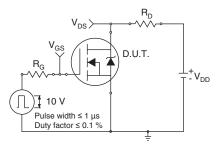


Fig. 10a - Switching Time Test Circuit

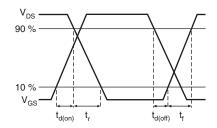


Fig. 10b - Switching Time Waveforms

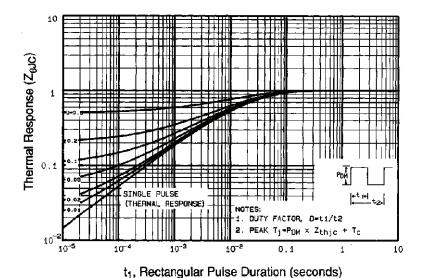


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

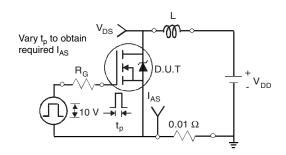


Fig. 12a - Unclamped Inductive Test Circuit

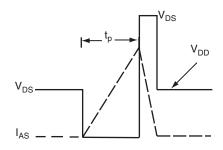


Fig. 12b - Unclamped Inductive Waveforms



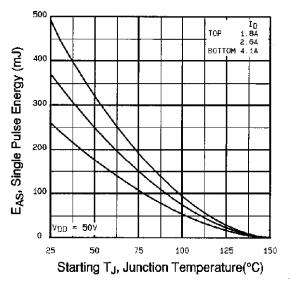


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

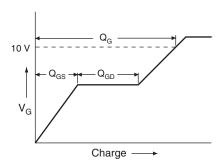


Fig. 13a - Basic Gate Charge Waveform

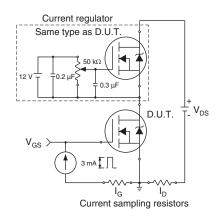
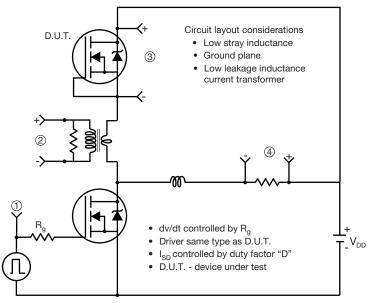


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dv/dt Test Circuit



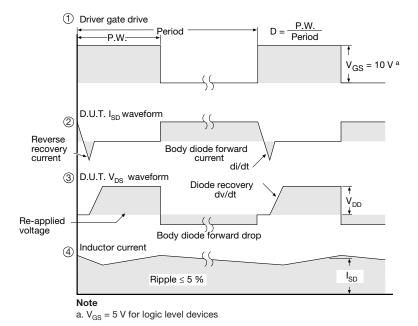


Fig. 14 - For N-Channel

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